

# BEST AVAILABLE COPY

## SEARCHED

Class	Sub.	Date	Exmr.
716	1	04/2003	Thompson
716	4	04/2003	↓
716	5	04/2003	↓
716	16	04/2003	↓
716	1	01/2004	Thompson
716	4	↓	↓
716	5	↓	↓
716	15	↓	↓

## INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	Date	Exmr.
ACM; IEEE; USPAT; USPGPB; DERWEST; eg. circuit and self- test configuration and memory and cooperation Inventor Name Search. (some search notes attached)	04/2003	Thompson
USPAT; USPGPB; DERWEST.	01/2004	Thompson